Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/771,396	HOJO ET AL.	
Examiner	Art Unit	
Rin A Lee	1713	

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	SEAR	CHED	
Class	Subclass	Date	Examiner
525	333.1_	JAN-1029	06m
525	332.6		
515	333.5	→	
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INT	ERFERENC	RFERENCE SEARCHED			
Class	Subclass	Date	Examiner		
525	333.1_	JAN10-25	m_	_	
525	332.6	JAN 22-29	W	_	
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
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